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May 2011

FDB86102LZ

N-Channel PowerTrench[®] MOSFET 100 V, 30 A, 24 m Ω

Features

- Max $r_{DS(on)} = 24 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 8.3 \text{ A}$
- Max $r_{DS(on)}$ = 35 m Ω at V_{GS} = 4.5 V, I_D = 6.8 A
- HBM ESD protection level > 6 kV typical (Note 4)
- Very low Qg and Qgd compared to competing trench technologies
- Fast switching speed
- 100% UIL Tested
- RoHS Compliant

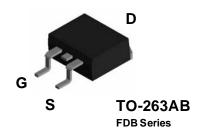


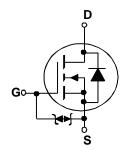
General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that has been especially tailored to minimize the on-state resistance and switching loss. G-S zener has been added to enhance ESD voltage level.

Applications

- DC-DC conversion
- Inverter
- Synchronous Rectifier





MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter		Ratings	Units
V_{DS}	Drain to Source Voltage		100	V
V_{GS}	Gate to Source Voltage		±20	V
	Drain Current -Continuous(Package limited) Tc = 25 °C		30	
	-Continuous (Silicon limited) Tc = 25 °C		40	Α
ID	-Continuous TA = 25 °C (N	Note 1a)	8.3	A
	-Pulsed		50	
E _{AS}	Single Pulse Avalanche Energy	(Note 3)	121	mJ
D	Power Dissipation $T_A = 25 ^{\circ}\text{C}$	Note 1a)	3.1	W
P_{D}	Power Dissipation $T_A = 25 ^{\circ}\text{C}$	Note 1b)	2	VV
T_J , T_{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Note 1)	1.9	°C/M
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	40	*C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDB86102LZ	FDB86102LZ	TO-263AB	330mm	24 mm	800 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV_DSS	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		69		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 80 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μΑ

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.0	1.5	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		-6		mV/°C
		$V_{GS} = 10 \text{ V}, I_D = 8.3 \text{ A}$		18	24	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 6.8 \text{ A}$		23	35	mΩ
		$V_{GS} = 10 \text{ V}, I_D = 8.3 \text{ A}, T_J = 125 ^{\circ}\text{C}$		31	42	
g _{FS}	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 8.3 \text{ A}$		29		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 50.V.V 0.V	959	1275	pF
C _{oss}	Output Capacitance	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1 \text{MHz}$	181	240	pF
C _{rss}	Reverse Transfer Capacitance	1 - 111112	9	13	pF
R_g	Gate Resistance		0.4		Ω

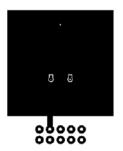
Switching Characteristics

t _{d(on)}	Turn-On Delay Time		6.6	13	ns
t _r	Rise Time	$V_{DD} = 50 \text{ V}, I_{D} = 8.3 \text{ A},$	2.1	10	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	18.2	33	ns
t _f	Fall Time		2.3	10	ns
$Q_{g(TOT)}$	Total Gate Charge	V _{GS} = 0 V to 10 V	15.2	21	nC
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V} V_{DD} = 50 \text{ V},$	7.6	11	nC
Q _{gs}	Gate to Source Charge	I _D = 8.3 A	2.4		nC
Q_{gd}	Gate to Drain "Miller" Charge		2.5		nC

Drain-Source Diode Characteristics

Veb Source to Diain Dioge Forward voltage	ource to Drain Diode, Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 8.3 \text{ A}$ (Note 2)	8.0	1.3	V
	$V_{GS} = 0 \text{ V}, I_{S} = 2.4 \text{ A}$ (Note 2)	0.7	1.2	V	
t _{rr}	Reverse Recovery Time	I _E = 8.3 A, di/dt = 100 A/μs		42	67	ns
Q _{rr}	Reverse Recovery Charge	- 1 _F = 0.5 A, αι/αι = 100 Α/μδ		40	64	nC

1. R_{0,1A} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,1C} is guaranteed by design while R_{0,CA} is determined by the user's board design.



a) 40 °C/W when mounted on a 1 in² pad of 2 oz copper



b) 62.5 °C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0 %. 3. Starting $T_J = 25$ °C, L = 3 mH, $I_{AS} = 9$ A, $V_{DD} = 100$ V, $V_{GS} = 10$ V. 4. The diode connected between gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics T_J = 25°C unless otherwise noted

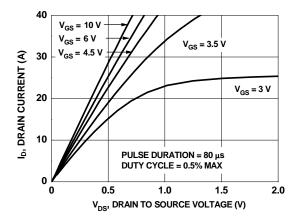


Figure 1. On Region Characteristics

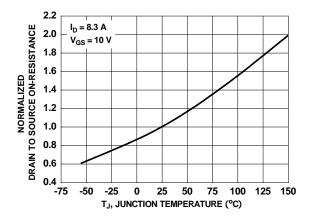


Figure 3. Normalized On Resistance vs Junction Temperature

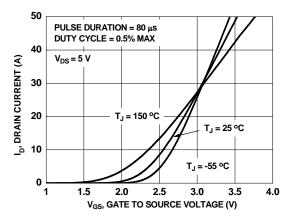


Figure 5. Transfer Characteristics

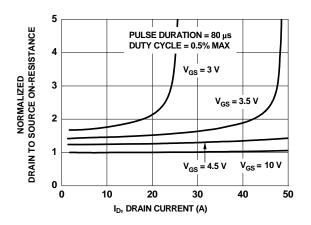


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

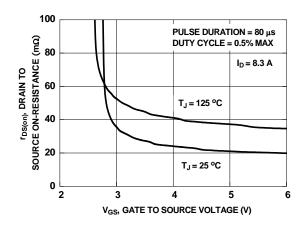


Figure 4. On-Resistance vs Gate to Source Voltage

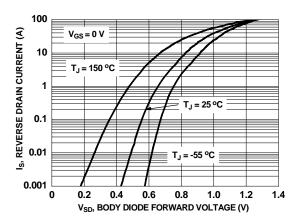


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25°C unless otherwise noted

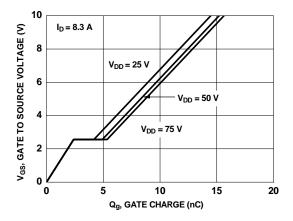


Figure 7. Gate Charge Characteristics

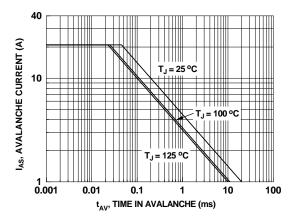


Figure 9. Unclamped Inductive Switching Capability

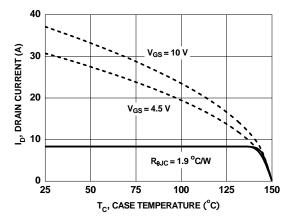


Figure 11. Maximum Continuous Drain Current vs Case Temperature

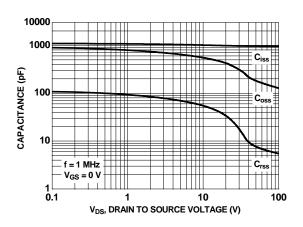


Figure 8. Capacitance vs Drain to Source Voltage

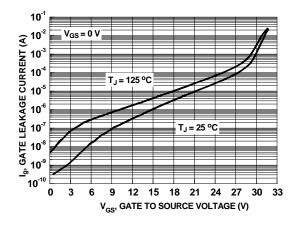


Figure 10. Gate Leakage Cuurent vs Gate to Source Voltage

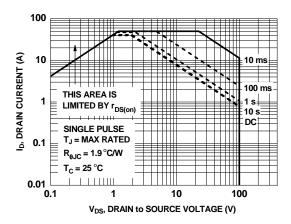


Figure 12. Forward Bias Safe Operating Area

Typical Characteristics T_J = 25°C unless otherwise noted

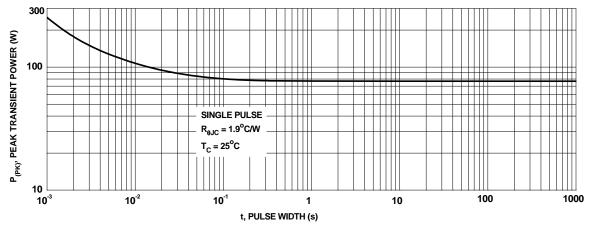


Figure 13. Single Pulse Maximum Power Dissipation

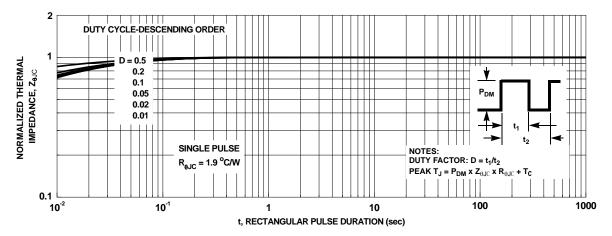


Figure 14. Junction-to-Case Transient Thermal Response Curve





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